Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/614,632	BEYERS ET AL.		
Examiner	Art Unit		
Allen Wong	2613		

	CEARCHER					
	SEARCHED					
Class	Subclass	Date	Examiner			
375	240.26	5/12/2005	AW			
375	240	5/12/2005	AW			
375	240.01	5/12/2005	AW			
375	240.12	5/12/2005	AW			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
375	240.26	5/12/2005	AW		
375	240	5/12/2005	AW		
375	240.01	5/12/2005	AW		
375/240.12		5/12/2005	AW		

SEARCH NOT (INCLUDING SEARCH)
_	DATE	EXMR
Anand Rao (Primary Examiner A.U. 2613)	5/12/2005	AW
Chris Kelley (SPE A.U. 2613)	5/12/2005	- AW
Young Lee (Primary Examiner A.U. 2613)	5/12/2005	AW
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